OIPETSMC-03-337

December 1, 2003

To: Commissioner for Patents

P.O.Box 1450

Alexandria, VA 22313-1450

Fr: George O. Saile, Req. No. 19,572

28 Davis Avenue

Poughkeepsie, N.Y. 12603

*Subject:

Serial No. 10/655,689 09/05/03

Yian-Liang Kuo et al.

AN SBGA DESIGN FOR LOW-K INTEGRATED | CIRCUITS (IC)

INFORMATION DISCLOSURE STATEMENT

Enclosed is Form PTO-1449, Information Disclosure Citation In An Application.

The following Patents and/or Publications are submitted to comply with the duty of disclosure under CFR 1.97-1.99 and 37 CFR 1.56. Copies of each document is included herewith.

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on December (, 2003.

Stephen B. Ackerman, Reg.# 37761

Signature/Date ____(

TSMC-03-337

- U.S. Patent 5,977,633 to Suzuki et al., "Semiconductor Device with Metal Base Substrate Having Hollows," describes a semiconductor device with metal base substrate having hollows.
- U.S. Patent 5,223,741 to Bechtel et al., "Package for an Integrated Circuit," describes a package for an integrated circuit structure.
- U.S. Patent 5,585,671 to Nagesh et al., "Reliable Low Thermal Resistance Package for High Power Flip Clip IC's," describes a low thermal resistance package for high power flip chip IC's.
- U.S. Patent 6,462,410 to Novotny et al., "Integrated Circuit Component Temperature Gradient Reducer," describes an integrated circuit component temperature gradient reducer.
- U.S. Patent 4,748,495 to Kucharek, "High Density Multi-Chip Interconnection and Cooling Package," describes a high density mulitchip interconnection and cooling package.

Sincerely,

Stephen B. Ackerman,

Reg. No. 37761

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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.